

Notice of References Cited	Application/Control No. 10/624,628	Applicant(s)/Patent Under Reexamination TRAN, LUAN C.	
	Examiner Scott Geyer	Art Unit 2812	Page 1 of 1

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*	C	US-6,599,792	07-2003	Jung, Woo-chan	438/199
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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